

## PATENT ABSTRACTS OF JAPAN

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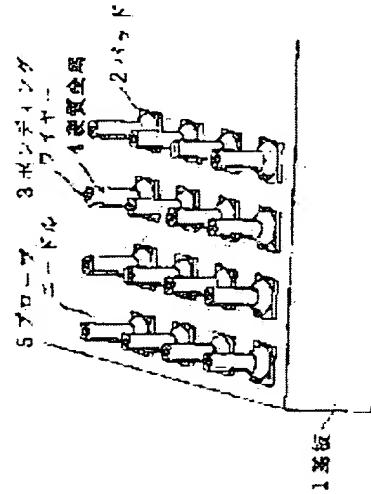
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## (54) MICRO-PROBE BOARD

## (57)Abstract:

PURPOSE: To collectively perform the probing of an electronic part having matrix like electrode arrangement and to improve high frequency characteristics.

CONSTITUTION: An electronic part having electrodes arranged thereto at a fine pitch in a matrix form is brought into contact with a micro-probe board equipped with probe needles 5 each formed by covering a bonding wire 3 being a core with a hard metal 4 to take continuity and a predetermined test signal is applied to the electronic part from the micro-probe board to perform a test.



## LEGAL STATUS

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